

Search Notes

Application/Control No.

09/590,027

Examiner

Chau Nguyen

Applicant(s)/Patent under
Reexamination

KLEIMAN, STEVEN R.

Art Unit

2176

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 709 | 203 | 5/20/2003 | CN |
| 709 | 212 | 5/20/2003 | CN |
| 709 | 228 | 5/20/2003 | CN |
| 709 | 238 | 5/20/2003 | CN |
| 710 | 52-53 | 12/30/2005 | CN |
| 710 | 56 | 12/30/2005 | CN |
| 710 | 308 | 12/30/2005 | CN |
| 710 | 310 | 12/30/2005 | CN |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--------------------------------|------------|------|
| East Reports | 05/02/2003 | CN |
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| | 05/22/2003 | CN |
| | 05/23/2003 | CN |
| Updated search on East Reports | 12/30/2003 | CN |

Search Notes (continued)

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| Class | Subclass | Date | Examiner |
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| 709 | 213 | 8/9/2005 | CN |
| 709 | 232 | 8/9/2005 | CN |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--------------------------------|------------|------|
| Updated Search on East Reports | 08/20/2004 | CN |
| | 8/22/2004 | CN |
| Updated Search on East Report | 02/23/2005 | CN |
| | 02/24/2005 | CN |
| | 02/25/2005 | CN |
| Updated Search on East Report | 08/09/2005 | CN |
| Updated Search on East Report | 12/30/2005 | CN |
| NPL Search on IEEE Database | 12/30/2005 | CN |